


<b>Search Notes</b>  	<b>Application/Control No.</b>  10597517	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAHARA ET AL.
	<b>Examiner</b>  Kwang Han	<b>Art Unit</b>  1727

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	3/24/2009	KH
Text search of class 429	3/24/2009	KH
See EAST search notes	3/24/2009	KH
STIC search	11/6/2009	KH
See updated EAST search notes	8/24/2011	KH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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